## Notice of References Cited Application/Control No. 10/537,027 Applicant(s)/Patent Under Reexamination DEN HEUVEL ET AL. Examiner Jeffrey R. West Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,916,291	07-2005	Givens et al.	600/559
*	В	US-5,626,629	05-1997	Faltys et al.	607/57
*	С	US-5,909,497	06-1999	Alexandrescu, Eugene	381/312
*	D	US-6,334,072	12-2001	Leysieffer, Hans	607/57
*	Е	US-6,115,478	09-2000	Schneider, Anthony Todd	381/314
*	F	US-6,879,693	04-2005	Miller et al.	381/60
*	G	US-2002/0176584	11-2002	Kates, James Mitchell	381/60
*	Η	US-6,366,863	04-2002	Bye et al.	702/57
*	I	US-6,115,478	09-2000	Schneider, Anthony Todd	381/314
*	J	US-4,847,617	07-1989	Silvian, Sergiu	340/870.16
*	К	US-5,609,616	03-1997	Schulman et al.	607/56
*	L	US-7,181,297	02-2007	Pluvinage et al.	700/94
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 0124930 B1	06-1990	EP	Crosby et al.	A61F 11/04
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.